**Product data sheet** 

## 1. General description

WG30N65MFB1 uses advanced Fine Trench Field-stop IGBT technology with anti-parallel diode in TO263 package to provide extremely low Vce(sat), and excellent switching performance. This device offers Best-in-Class efficiency in hard switching and resonant topology.





### 2. Features and benefits

- · Maximum junction temperature 175 °C
- · Positive Temperature efficient for easy paralleling
- · Very soft, fast recovery anti-parallel diode
- · Smooth & Optimized switching
- · EMI Improved Design

## 3. Applications

- PFC
- Solar converters
- UPS
- Welding Converters
- · Mid to high range switching frequency converters

### 4. Quick reference data

#### Table 1. Quick reference data

Symbol	Parameter		Notes		Value		Unit
V <sub>CE</sub>	Collector-emitter voltage, T <sub>j</sub> ≥ 25 °C			650			V
I <sub>C</sub>	DC collector current, limited by $T_{j(max)}$ $T_C = 100  ^{\circ}C$				30		A
Symbol	Parameter Conditions		Notes	Min	Тур	Max	Unit
Static characteristics							
V <sub>CE(sat)</sub>	Collector-emitter saturation voltage	$V_{GE} = 15 \text{ V}; I_{C} = 30 \text{ A}; T_{j} = 25 ^{\circ}\text{C}$		-	1.6	2.1	V

# 5. Pinning information

**Table 2. Pinning information** 

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		•C
2	С	collector [1]	p a	
3	Е	emitter		
mb	С	mounting base; connected to collector		G E sym200

<sup>[1]</sup> it is not possible to connect to pin 2 of the TO-263 package.

# 6. Ordering information

**Table 3. Ordering information** 

Type number	Package Name	Orderable part number	Packing method	Small packing quantity	Package version	Package issue date
WG30N65MFB1	TO263	WG30N65MFB1J	Reel	800	TO263P	12-Jun-2023

# 7. Marking

Table 4. Marking codes

Type number	Marking codes
WG30N65MFB1	G30N65 MFB1

# 8. Limiting values

### Table 5. Limiting values

Symbol	Parameter	Notes	Value	Unit
$V_{CE}$	Collector-emitter voltage, T <sub>j</sub> ≥ 25 °C		650	V
I <sub>c</sub>	DC collector current, limited by $T_{j(max)}$ $T_{C}$ = 25 °C $T_{C}$ = 100 °C		60 30	А
I <sub>C(puls)</sub>	Pulsed collector current, $t_p$ limited by $T_{j(max)}$		90	А
-	Turn off safe operating area $V_{CE} \le 650 \text{ V}, T_j \le 175 ^{\circ}\text{C}, t_p = 1  \mu\text{s}$		90	А
I <sub>F</sub>	Diode forward current, limited by $T_{j(max)}$ $T_{C}$ = 25 °C $T_{C}$ = 100 °C		60 30	А
I <sub>Fpuls</sub>	Diode pulsed current, t <sub>p</sub> limited by T <sub>j(max)</sub>		90	Α
$V_{GE}$	Gate-emitter voltage		±20	V
P <sub>tot</sub>	Power dissipation $T_C = 25 ^{\circ}\text{C}$ Power dissipation $T_C = 100 ^{\circ}\text{C}$		312 156	W
t <sub>sc</sub>	Short circuit withstand time $V_{GE}$ = 15.0 V, $V_{CC}$ ≤ 400 V Allowed number of short circuits < 1000 Time between short circuits: ≥ 1.0 s $T_j$ = 175°C		5	us
T <sub>stg</sub>	Storage temperature		-55 to +150	°C
T <sub>jmax</sub>	Maximum operating junction temperature		175	°C
-	Peak soldering temperture		260	°C
M	Mounting Torque with washer		0.55	Nm

### 9. Thermal characteristics

**Table 6. Thermal characteristics** 

Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
$R_{\text{th(j-c)}}$	IGBT thermal resistance from junction to case			-	0.48	-	K/W
$R_{\text{th(j-c)}}$	Diode thermal resistance from junction to case			-	0.94	-	K/W
$R_{\text{th(j-a)}}$	thermal resistance from junction to ambient			-	40	-	K/W

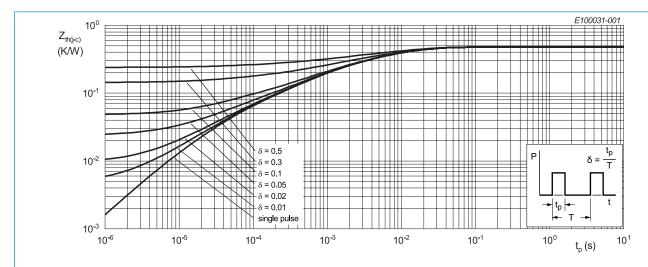


Fig. 1. Transient thermal impedance from junction to case as a function of pulse duration; IGBT

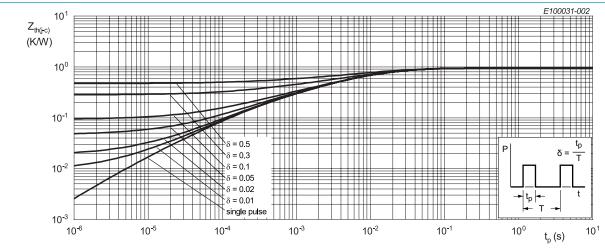


Fig. 2. Transient thermal impedance from junction to case as a function of pulse duration; Diode

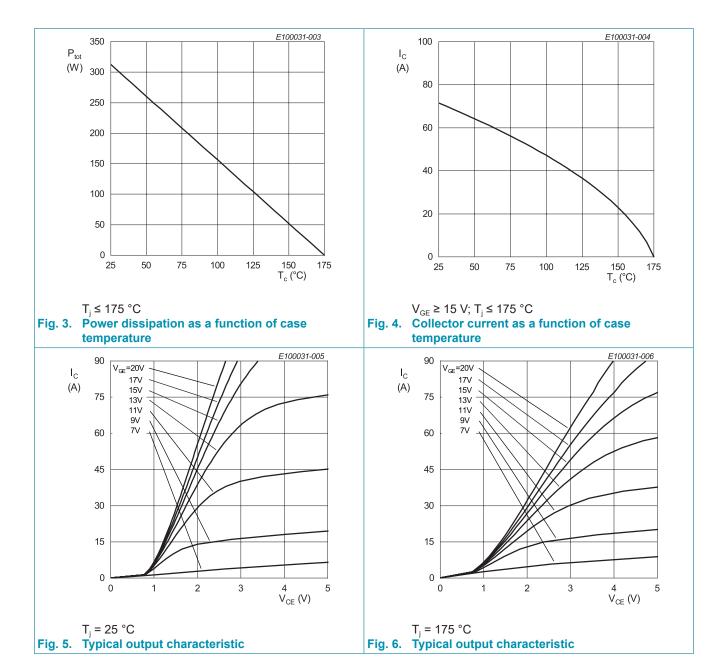
## 10. Characteristics

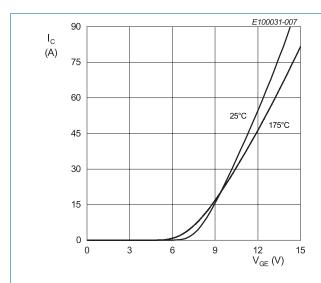
#### **Table 7. Characteristics**

Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
Static cha	racteristics						
$BV_CES$	Collector-emitter breakdown voltage	$V_{GE} = 0 \text{ V}; I_{C} = 1.0 \text{ mA}$		650	-	-	V
$V_{\text{CE(sat)}}$	Collector-emitter saturation	$V_{GE} = 15 \text{ V}; I_{C} = 30 \text{ A}; T_{j} = 25 \text{ °C}$		-	1.6	2.1	V
	voltage	$V_{GE}$ = 15 V; $I_{C}$ = 30 A; $T_{j}$ = 175 °C		-	2.1	-	V
V <sub>F</sub>	Diode forward voltage	$V_{GE} = 0 \text{ V}; I_F = 30 \text{ A}; T_j = 25 \text{ °C}$		-	1.9	-	V
		$V_{GE} = 0 \text{ V}; I_F = 30 \text{ A}; T_j = 175 \text{ °C}$		-	1.5	-	V
$V_{\text{GE(th)}}$	Gate-emitter threhold voltage	$I_{\rm C}$ = 0.6 mA; $V_{\rm CE}$ = $V_{\rm GE}$		4.3	5.5	6.6	V
I <sub>CES</sub>	Zero gate voltage collector	$V_{CE} = 650 \text{ V}; V_{GE} = 0 \text{ V}; T_j = 25 \text{ °C}$		-	-	100	μA
	current	$V_{CE} = 650 \text{ V}; V_{GE} = 0 \text{ V}; T_j = 175 ^{\circ}\text{C}$		-	-	1	mA
g <sub>fs</sub>	Transconductance	V <sub>CE</sub> = 20 V; I <sub>C</sub> = 30 A		-	13	-	S
Dynamic	characteristics						
C <sub>ies</sub>	Input capacitance	$V_{CE} = 30 \text{ V}; V_{GE} = 0 \text{ V}; f = 1 \text{ MHz};$		-	1626	-	pF
C <sub>oes</sub>	Output capacitance	T <sub>j</sub> = 25 °C		-	84	-	pF
C <sub>res</sub>	Reverse transfer capacitance			-	17	-	pF
$Q_{G}$	Gate charge	$V_{CC}$ = 520 V; $I_{C}$ = 30 A; $V_{GE}$ = 15 V; $T_{j}$ = 25 °C		-	70	-	nC

# 11. Switching Characteristics

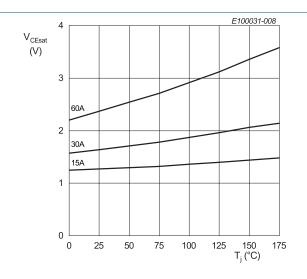
Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
IGBT cha	racteristics						
$t_{d(on)}$	Turn-on delay time	T <sub>j</sub> = 25 °C;		-	32	-	nS
t <sub>r</sub>	Rise time	$V_{CC} = 400 \text{ V}; I_C = 30 \text{ A}; V_{GE} = 15 \text{V} / 0 \text{V};$ $R_G = 10 \Omega$		-	39	-	nS
$t_{d(off)}$	Turn-off delay time			-	119	-	nS
t <sub>f</sub>	Fall time			-	38	-	nS
E <sub>on</sub>	Turn-on energy			-	0.7	-	mJ
E <sub>off</sub>	Turn-off energy			-	0.38	-	mJ
E <sub>ts</sub>	Total switching energy			-	1.08	-	mJ
t <sub>d(on)</sub>	Turn-on delay time	$T_{j}$ = 175 °C; $V_{CC}$ = 400 V; $I_{C}$ = 30 A; $V_{GE}$ = 15V / 0V; $R_{G}$ = 10 $\Omega$		-	32	-	nS
t <sub>r</sub>	Rise time			-	40	-	nS
$t_{d(off)}$	Turn-off delay time			-	137	-	nS
t <sub>f</sub>	Fall time			-	71	-	nS
E <sub>on</sub>	Turn-on energy			-	1.3	-	mJ
E <sub>off</sub>	Turn-off energy			-	0.6	-	mJ
E <sub>ts</sub>	Total switching energy			-	1.9	-	mJ
Diode cha	aracteristics		ı	1			
t <sub>rr</sub>	Reverse recovery time	T <sub>j</sub> = 25 °C;		-	44	-	nS
Q <sub>r</sub>	Reverse recovery charge	$V_R = 400 \text{ V}; I_F = 30 \text{ A}; dI_F/dt = 500 \text{A/us}$		-	221	-	nC
I <sub>RM</sub>	Reverse recovery peak current			-	9	-	А
t <sub>rr</sub>	Reverse recovery time	T <sub>j</sub> = 175 °C;		-	100	-	nS
Q <sub>r</sub>	Reverse recovery charge	$V_R = 400 \text{ V}; I_F = 30 \text{ A}; dI_F/dt = 500 \text{A/us}$		-	990	-	nC
I <sub>RM</sub>	Reverse recovery peak current			-	17	-	А





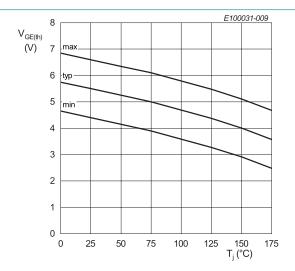
 $V_{CE} = 20 \text{ V}$ 

Fig. 7. Typical transfer characteristic



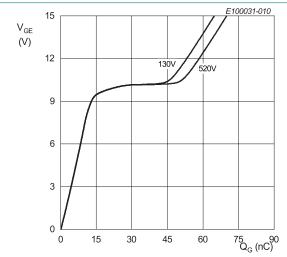
 $V_{GE} = 15 V$ 

Fig. 8. Typical collector-emitter saturation voltage as a function of junction temperature



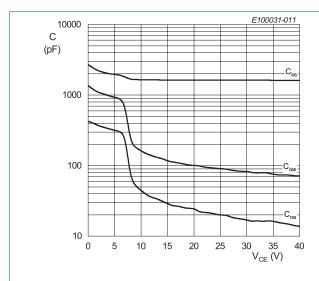
 $I_{c} = 600 \, \mu A$ 

Fig. 9. Gate-emitter threshold voltage as a function of junction temperature



 $I_{c} = 30 \text{ A}$ 

Fig. 10. Typical gate charge



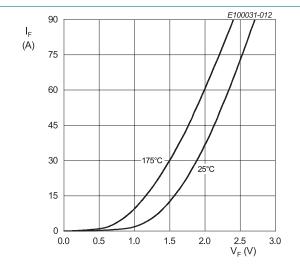
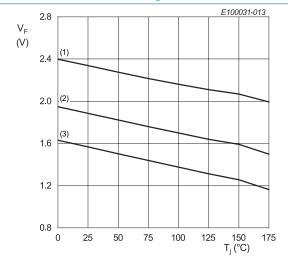
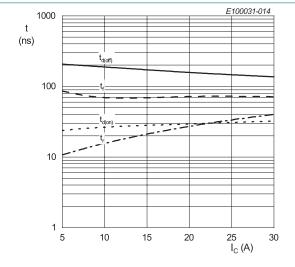


Fig. 12. Typical diode forward current as a function of forward voltage

 $\label{eq:VGE} V_{GE} = 0 \ V; \ f = 1 \ MHz$  Fig. 11. Typical capacitance as a function of collector-emitter voltage





(1)  $I_F = 60 A$ (2)  $I_F = 30 A$ 

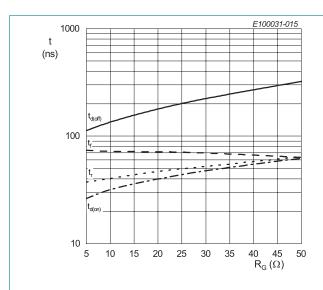
(3)  $I_F = 15 A$ 

 $R_{g}$  = 10  $\Omega;$   $V_{GE}$  = 15V/0V;  $T_{j}$  = 175 °C;  $V_{CE}$  = 400 V; inductive load

Fig. 13. Typical diode forward voltage as a function of junction temperature

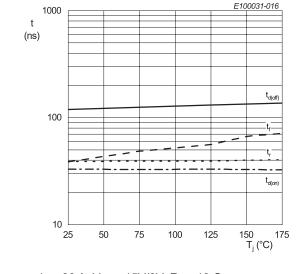
Fig. 14. Typical switching times as a function of collector current

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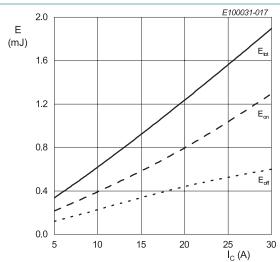
 $I_C$  = 30 A;  $V_{GE}$  = 15V/0V;  $T_j$  = 175 °C;  $V_{CE}$  = 400 V; inductive load

Fig. 15. Typical switching times as a function of gate resistance



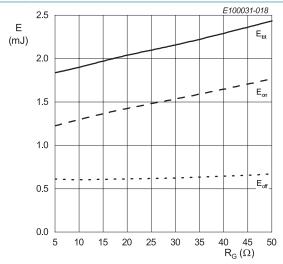
 $I_{C}$  = 30 A;  $V_{GE}$  = 15V/0V;  $R_{g}$  = 10  $\Omega$ ;  $V_{CE}$  = 400 V; inductive load

Fig. 16. Typical switching times as a function of junction temperature



$$\begin{split} R_g = 10~\Omega;~V_{GE} = 15 \text{V/0V};~T_j = 175~^{\circ}\text{C};\\ V_{CE} = 400~\text{V};~inductive~load \end{split}$$
 Fig. 17. Typical switching energy losses as a function

of collector current

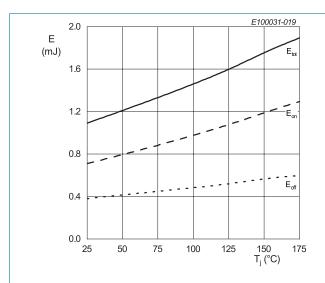


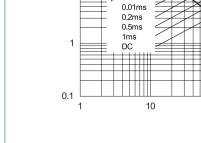
 $I_{C}$  = 30 A;  $V_{GE}$  = 15V/0V;  $T_{j}$  = 175 °C;  $V_{CE}$  = 400 V; inductive load

Fig. 18. Typical switching energy losses as a function of gate resistance

1000

 $V_{CE}(V)$ 





 $I_{\rm C}$ 

(A)

100

10

 $I_{\text{C}}$  = 30 A;  $V_{\text{GE}}$  = 15V/0V;  $R_{\text{g}}$  = 10  $\Omega;$   $V_{\text{CE}}$  = 400 V; inductive load

Fig. 19. Typical switching energy losses as a function of junction temperature

Fig. 20. Forward bias safe operating area

= 0.001ms

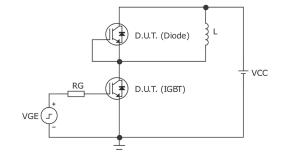


Fig. 21. Test circuit for inductive load switching

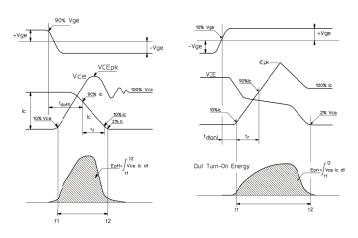
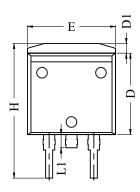


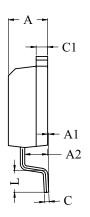
Fig. 22. Definition of switching times and losses

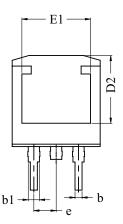
# 12. Package outline

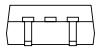
Plastic single-ended surface-mounted package (D2PAK); 3 leads (one lead cropped)

TO263









Dim	All Dimensions in Millimeters				
Dilli	Min	Тур	Max		
A	4.30	4.46	4.60		
A1	0	0.13	0.25		
A2	2.50	2.60	2.70		
ь	0.70	0.80	0.90		
b1	1.10	1.27	1.45		
С	0.40	0.52	0.60		
C1	1.17	1.30	1.40		
D	9.10	9.25	9.40		
D1	1.00	1.10	1.30		
D2	7.40	7.70	8.00		
Е	9.80	10.00	10.20		
E1	7.60	7.80	8.00		
e		2.54 BSC			
Н	14.80	15.30	15.80		
L	2.10	2.47	2.80		
L1	1.30	1.50	1.70		

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### 13. Legal information

#### Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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## 14. Contents

1. General description	1
2. Features and benefits	1
3. Applications	1
4. Quick reference data	1
5. Pinning information	2
6. Ordering information	2
7. Marking	2
8. Limiting values	3
9. Thermal characteristics	4
10. Characteristics	5
11. Switching Characteristics	6
12. Package outline	
13. Legal information	13
14. Contents	

For more information, please visit: http://www.ween-semi.com
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Date of release: 29 November 2023

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